

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re U.S. Patent Application of)
NAKAZAWA et al.)
Application Number: To be Assigned)
Filed: Concurrently Herewith)
For: A SEMICONDUCTOR DEVICE AND A METHOD OF)
MANUFACTURING THE SAME)
ATTORNEY DOCKET NO. HITA.0544)

**Honorable Assistant Commissioner
for Patents
Washington, D.C. 20231**

INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to 37 C.F.R. §§ 1.56 and 1.97, this Information Disclosure Statement is submitted in the above-identified patent application. A listing of documents to be published on the face of any patent granted from this application is submitted herewith on Form PTO-1449. Any other documents or information submitted for consideration by the Examiner are listed in this paper. A copy of each U.S. and foreign patent, or each publication or portion thereof listed or herein identified, is submitted herewith.

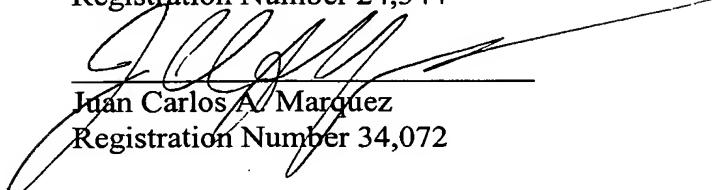
This Information Disclosure Statement is submitted with the initial filing of the application. Accordingly, no fee is due or payable at this time.

The Examiner is requested to acknowledge consideration of the information provided in this paper in accordance with prescribed procedures.

Please charge any additional fees or credit any overpayments in connection with this paper to Deposit Account No. 08-1480.

Respectfully submitted,

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April 20, 2004

Form PTO 1449 U.S. Department of Commerce Patent and Trademark Office Information Disclosure Statement by Applicant	ATTY. DOCKET NUMBER HITA.0544	SERIAL NUMBER To be Assigned
	APPLICANT NAKAZAWA et al.	
	FILING DATE Concurrently Herewith	GROUP

U.S. Patent Documents

Foreign Patent Documents

EXAMINER INITIAL		DOCUMENT NUMBER	FILING DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO
		6-151867	11/13/92	Japan			Abstract	X
		2001-168329	12/13/99	Japan			Abstract	X
		2002-353452	5/25/2001	Japan			Abstract	X
		10-173175	12/9/96	Japan			Abstract	X
		10-56174	8/9/96	Japan			Abstract	X
		2002-231944	1/31/2001	Japan			Abstract	X

Other Documents (Including Author, Title, Date Pertinent Pages, Etc.)

		Case Examinations (including Plaintiff, Time, Date of Examination, Etc.)
EXAMINER		DATE CONSIDERED

EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant